# NGTD17R120F2

# **Fast Switching Rectifier Die**

Fast switching low Vf rectifier die for free-wheeling applications.

### Features

- Fast Switching
- Low Vf

### **Typical Applications**

- Industrial Motor Control
- Solar PV Inverters

### MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Peak Reverse Voltage	V <sub>RRM</sub>	1200	V
Max Forward Conduction Current	۱ <sub>F</sub>	(Note 1)	А
Maximum Junction Temperature	ТJ	175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Depending on thermal properties of assembly.

### **MECHANICAL DATA**

Parameter	Value	Unit	
Die Size	4000 x 4000	μm²	
Die Thickness	5.5	mils	
Wafer Size	150	mm	
Top Pad Size (Anode)	3380 x 3380	μm²	
Top Metal (Anode)	4 μm AlSi		
Back Metal (Cathode)	2 μm TiNiAg		
Max possible chips per wafer	769		
Passivation frontside	Oxide-Nitride		
Reject ink dot size	25 mils		
Recommended storage environment: In original container, in dry nitrogen, or temperature of 18–28°C, 30–65%RH	Type: Bare Wafer in Jar Storage time: < 36 months	Type: Die on tape in ring-pack Storage time: < 3 months	

### **ORDERING INFORMATION**

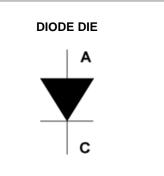
Device	Inking?	Shipping		
NGTD17R120F2WP	Yes	Bare Wafer in Jar		
NGTD17R120F2SWK	Yes	Sawn Wafer on Tape		

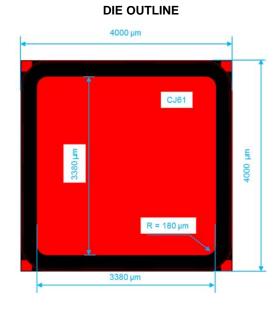


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V<sub>RRM</sub> = 1200 V I<sub>F</sub> = Limited by T<sub>J(max)</sub>





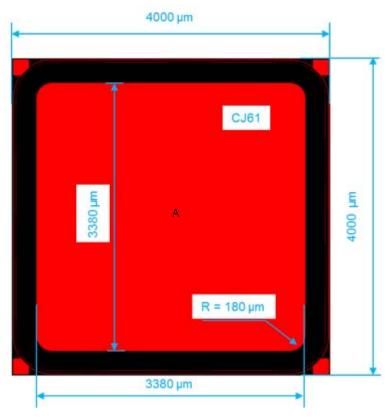
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### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C, unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Units
STATIC CHARACTERISTICS						
Forward Voltage	I <sub>F</sub> = 35 A, T <sub>J</sub> = 25°C	V <sub>F</sub>		1.8		V
Reverse Voltage	$I_R = 400 \ \mu A, \ T_J = 25^{\circ}C$	V <sub>R</sub>	1200			V
Reverse Current	$V_{R} = 1200 \text{ V}, \text{ T}_{J} = 25^{\circ}\text{C}$	I <sub>R</sub>	-1.0		1.0	μA

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

## DIE LAYOUT



A = Anode pad All dimensions in  $\mu m$ 

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#### **Further Electrical Characteristic**

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

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